

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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		Examiner	Art Unit	Page 1 of 1
		Taeyoon Kim	1651	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0098552 A1	07-2002	Livshits et al.	435/88
	B	US-			
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	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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